Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10561089	HAYASHI ET AL.
Examiner	Art Unit
Long Pham	2814

SEARCHED				
Class	Subclass	Date	Examiner	
257	374, 506, 513, 516, 531	02/14/2010	LP	

SEARCH NOTES		
Search Notes	Date	Examiner
Updated text and interference searches	02/14/2010	LP

		INTERFERENCE SE	ARCH	
Class		Subclass	Date	Examiner
257	374		02/14/2010	LP

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